



LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>					ATTY. DOCKET NO.:		APPLICATION SERIAL NO.:	
					4717-8600		10/726, 039	
					APPLICANT:			
					Bruno GHYSELEN et al.			
					FILING DATE:		GROUP:	
					December 1, 2003		2812	

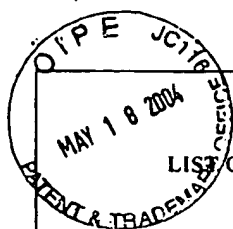
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
Dle	AA	5,882,987 ✓	3/1999	Srikrishnan	438	458	
	AB	6,284,628 B1	9/2001	Kuwahara et al.	438	459	
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
Dle	AG	EP 0 955 671 A1	11/1999	Europe			X	
	AH	EP 1 039 513 A2	9/2000	Europe			X	
	AI	EP 0 926 709 A2	6/1999	Europe			X	
	AJ	WO 01/11930 A2	2/2001	PCT			X	

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Dle	AK	L. J. Huang et al, "SiGe-on-insulator prepared by wafer bonding and layer transfer for high-performance field-effect transistors", Applied Physics Letters, Vol. 78, No. 9, pp. 1267-1269 (2001)
Dle	AL	Q. Y. Tong et al "Extracts of "Semi-conductor on wafer bonding", Science and Technology, Interscience Technology, Wiley Interscience publication, Johnson Wiley & Sons, Inc.
	AM	

EXAMINER <div style="font-size: 2em; margin-top: 10px;">Dle</div>	DATE CONSIDERED <div style="font-size: 1.5em; margin-top: 10px;">4/2005</div>
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>De</i>	AA	6,375,738	4/2002	Sato	117	89	
	AB						
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	AE						
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<i>De</i>	AG	EP 1006 567 A2	6/2000	Europe			X	
	AH	EP 0 849 788 A2		Europe			X	
	AI	WO 99/53539	10/1999	PCT			X	
	AJ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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<div style="text-align: center;"> LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i> </div> <div style="position: absolute; left: 0; top: 50px; transform: rotate(-45deg); border: 1px solid black; border-radius: 50%; padding: 5px; width: 100px; text-align: center;"> O I P E JUL 20 2004 PATENT & TRADEMARK OFFICE </div>				ATTY. DOCKET NO.:		APPLICATION SERIAL NO.:	
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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
Dle	AA	2001/0029072 A1	10/2001	Kuwahara et al.	438	151	
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